

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10518451	BAE ET AL.
	Examiner	Art Unit
	Bui, Luan K	3728

SEARCHED

Class	Subclass	Date	Examiner
206	389,395,397,407-409	3/28/07	lkb
220	611,612,615,616,622,625,634-636,646		
229	4.5,5.5,5.7,93,122.3,122.31		
242	170-174,129,134,137,588.4,588.6		

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner